

$^{28}\text{Si}(\mu^-, \nu p n \gamma)$ **2007Me18**

Type	Author	History	Citation	Literature Cutoff Date
Full Evaluation	M. S. Basunia and A. M. Hurst		NDS 134,1 (2016)	1-Feb-2016

The μ^- beam obtained from decay of π^- beam at 90 MeV/c. Measured γ -ray yields using two HPGe detectors at TRIUMF facility.

 Muonic Lyman (or K) series for Silicon

μ x-ray	Energy	Intensity (in% per capture)
2p-1s	400.177 a)	80.3 8
3p-1s	476.80 5	7.40 20
4p-1s	503.58 10	4.27 20
5p-1s	515.97 10	3.83 20
6p-1s	522.74 10	2.29 10
(7p to ∞ p)-1s		1.87 20

a): 400.177-keV x ray used for calibration

 ^{26}Mg Levels

$E(\text{level})^\dagger$	J^π
0.0	0^+
1808.73	2^+
2938.34	2^+
3588.56	0^+
3941.55	3^+
4318.88	4^+
4332.57	2^+

† From Adopted Levels.

 $\gamma(^{26}\text{Mg})$

E_γ^\ddagger	I_γ^\ddagger	$E_i(\text{level})$	J_i^π	E_f	J_f^π	Comments
1003.25 4	0.25 5	3941.55	3^+	2938.34	2^+	
1129.61 4	2.11 14	2938.34	2^+	1808.73	2^+	
1779.74 8	<2.0	3588.56	0^+	1808.73	2^+	I_γ : masked by 1778.97 γ from ^{28}Si , mostly from ^{28}Al decay.
1808.68 4	7.9 8	1808.73	2^+	0.0	0^+	
2132.71 4	0.14 7	3941.55	3^+	1808.73	2^+	
2510.01 5	0.49 24	4318.88	4^+	1808.73	2^+	
2523.69 6	<0.13	4332.57	2^+	1808.73	2^+	
2938.15 5	0.52 23	2938.34	2^+	0.0	0^+	

‡ From Adopted Gammas.

‡ Percent yield per muon capture.

